

TPS22810 2.7~18V、79mΩオン抵抗、熱保護付き負荷スイッチ

1 特長

- シングル・チャンネル負荷スイッチを内蔵
 - 動作時周囲温度: -40°C~+105°C
 - SOT23-6 (DBV): 最大連続電流2A¹
 - WSON (DRV): 最大連続電流3A¹
 - 入力電圧範囲: 2.7V~18V
 - 絶対最大入力電圧: 20V
 - オン抵抗(R_{ON})
 - V_{IN} = 12VでR_{ON} = 79mΩ (標準値)
 - 静止電流
 - V_{IN} = 12Vにおいて62μA (標準値)
 - シャットダウン電流
 - V_{IN} = 12Vにおいて500nA (標準値)
 - サーマル・シャットダウン
 - 低電圧誤動作防止(UVLO)
 - 可変クイック出力放電(QOD)
 - CTピンで立ち上がり時間を設定可能
 - SOT23-6パッケージ
 - 2.9mm×2.8mm、0.95mmピッチ、高さ1.45mm (DBV)
 - WSONパッケージ
 - 2mm×2mm、0.65mmピッチ、高さ0.75mm (DRV)
 - ESD性能はJESD 22に準拠しテスト済み
 - HBM ±2kV、CDM ±1kV
- (1) 熱性能を考慮する必要があります

2 アプリケーション

- HDTV
- 産業用システム
- セットトップ・ボックス
- 監視システム

3 概要

TPS22810はシングル・チャンネルの負荷スイッチで、立ち上がり時間を設定可能、クイック出力放電(QOD)が内蔵されています。さらに、このデバイスには接合部温度の上昇からデバイスを保護するため、サーマル・シャットダウン機能が搭載されています。これらの機能により、デバイスの安全な動作が本質的に保証されています。このデバイスにはNチャンネルMOSFETが搭載され、2.7V~18Vの入力電圧範囲で動作できます。SOT23-5 (DBV)パッケージは最大で2Aの電流をサポートできます。WSON (DRV)パッケージは最大で3Aの電流をサポートできます。スイッチはオン/オフ入力により制御され、低電圧の制御信号と直接接続が可能です。

デバイスの立ち上がり時間を設定可能なため、大きな負荷容量により発生する突入電流が大幅に減少し、電源ドレープが低減、または生じなくなります。低電圧誤動作防止機能は、VIN電圧がスレッシュホールド値よりも低下した場合にデバイスの電源をオフにし、想定よりも低い電圧の供給によって下流の回路が損害を受けることを防止します。QODピンは設定可能で、デバイスの立ち下がり時間を制御し、電源オフ時の設計を柔軟に行えるようにします。

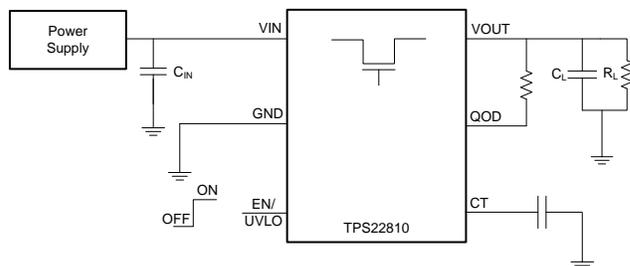
TPS22810はリード付きのSOT-23パッケージ(DBV)で供給され、ハンダ付け結合部を目視で検査できるほか、WSONパッケージ(DRV)でも供給されます。このデバイスは、-40°C~+105°Cの周囲温度範囲で動作するよう規定されています。

製品情報⁽¹⁾

型番	パッケージ	本体サイズ(公称)
TPS22810	SOT-23 (6)	2.90mm×2.80mm
	WSON (6)	2.00mm×2.00mm

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。

概略回路図



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目次

1	特長	1	9.4	Device Functional Modes	17
2	アプリケーション	1	10	Application and Implementation	18
3	概要	1	10.1	Application Information	18
4	改訂履歴	2	10.2	ON and OFF Control	18
5	Device Comparison Table	3	10.3	Input Capacitor (Optional)	18
6	Pin Configuration and Functions	3	10.4	Output Capacitor (Optional)	18
7	Specifications	4	10.5	Typical Application	18
7.1	Absolute Maximum Ratings	4	11	Power Supply Recommendations	23
7.2	ESD Ratings	4	12	Layout	24
7.3	Recommended Operating Conditions	4	12.1	Layout Guidelines	24
7.4	Thermal Information	4	12.2	Layout Example	24
7.5	Electrical Characteristics	5	12.3	Thermal Considerations	24
7.6	Switching Characteristics	7	13	デバイスおよびドキュメントのサポート	25
7.7	Typical DC Characteristics	8	13.1	デバイス・サポート	25
7.8	Typical AC Characteristics	9	13.2	ドキュメントのサポート	25
8	Parameter Measurement Information	11	13.3	ドキュメントの更新通知を受け取る方法	25
9	Detailed Description	12	13.4	コミュニティ・リソース	25
9.1	Overview	12	13.5	商標	25
9.2	Functional Block Diagram	13	13.6	静電気放電に関する注意事項	25
9.3	Feature Description	13	13.7	Glossary	25
			14	メカニカル、パッケージ、および注文情報	25

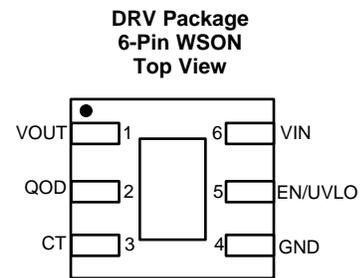
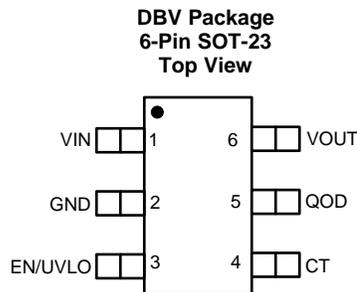
4 改訂履歴

Revision B (May 2017) から Revision C に変更	Page
<ul style="list-style-type: none"> Changed Rise time can be calculated by multiplying to Rise time can be calculated by dividing in the <i>Feature Description</i> Section 9.3.4 <i>Adjustable Rise Time (CT)</i>..... 	17
Revision A (December2016) から Revision B に変更	Page
<ul style="list-style-type: none"> 「特長」、「概要」セクション、「推奨動作条件」表に WSON (DRV) 電流の情報を追加 WSON (DRV) パッケージ 追加 	1 1
2016年12月発行のものから更新	Page
<ul style="list-style-type: none"> I_{MAX} および I_{PLS} を「絶対最大定格」表から削除 Deleted I_{MAX} and I_{PLS} from the <i>Absolute Maximum Ratings</i> table Changed the Quiescent current MAX value From: 70 μA To: 80 μA in the <i>Electrical Characteristics</i> table Changed the Quiescent current MAX value for $V_{IN} = 2.7$ V From: 60 μA To: 70 μA in the <i>Electrical Characteristics</i> table Changed the Shutdown current MAX value From: 2.25 μA To: 2.3 μA in the <i>Electrical Characteristics</i> table 	1 4 5 5 5

5 Device Comparison Table

DEVICE	R _{ON} at 12 V	Package	QUICK OUTPUT DISCHARGE	T _A	MAXIMUM OUTPUT CURRENT	ENABLE
TPS22810	79 mΩ	DBV	Configurable	105°C	2 A	Active High
TPS22810	79 mΩ	DRV	Configurable	105°C	3 A	Active High

6 Pin Configuration and Functions



Pin Functions

NAME	PIN NO,		I/O	DESCRIPTION
	SOT23	WSON		
CT	4	3	O	Switch slew rate control. Can be left floating
EN/UVLO	3	5	I	Active high switch control input and UVLO adjustment. Do not leave floating
GND	2	4	—	Device ground
QOD	5	2	O	Quick Output Discharge pin. This functionality can be enabled in one of three ways. <ul style="list-style-type: none"> Placing an external resistor between VOUT and QOD Tying QOD directly to VOUT and using the internal resistor value (R_{PD}) Disabling QOD by leaving pin floating See the Quick Output Discharge (QOD) for more information
VIN	1	6	I	Switch input. Place ceramic bypass capacitor(s) between this pin and GND
VOUT	6	1	O	Switch output

7 Specifications

7.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted) ⁽¹⁾ ⁽²⁾

		MIN	MAX	UNIT
V _{IN}	Input voltage	-0.3	20	V
V _{OUT}	Output voltage	-0.3	min(V _{IN} + 0.3, 20)	V
V _{EN/UVLO}	EN/UVLO voltage	-0.3	20	V
T _J	Maximum junction temperature		150	°C
T _{stg}	Storage temperature	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal.

7.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions.

7.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V _{IN}	Input voltage	2.7	18	V
V _{EN/UVLO}	EN/UVLO voltage	0	18	V
V _{OUT}	Output voltage		V _{IN}	V
I _{MAX}	Maximum continuous switch current, T _A = 65°C (DBV)		2	A
	Maximum continuous switch current, T _A = 65°C (DRV)		3	
T _A	Operating free-air temperature ⁽¹⁾	-40	105	°C
C _{IN}	Input capacitor	1 ⁽²⁾		µF

- (1) In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature [T_{A(MAX)}] is dependent on the maximum operating junction temperature [T_{J(MAX)}], the maximum power dissipation of the device in the application [P_{D(MAX)}], and the junction-to-ambient thermal resistance of the part/package in the application (θ_{JA}), as given by the following equation: T_{A(MAX)} = T_{J(MAX)} - (θ_{JA} × P_{D(MAX)}).
- (2) See the [Detailed Description](#) section.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾	TPS22810		UNIT	
	DBV (SOT23)	DRV (WSON)		
	6 PINS	6 PINS		
R _{θJA}	Junction-to-ambient thermal resistance	182	74.6	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	127.2	80.3	°C/W
R _{θJB}	Junction-to-board thermal resistance	16.9	44.3	°C/W
ψ _{JT}	Junction-to-top characterization parameter	26.4	3.2	°C/W
ψ _{JB}	Junction-to-board characterization parameter	36.3	44.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

7.5 Electrical Characteristics

Unless otherwise noted, the specification in the following table applies over the following ambient operating temperature $-40^{\circ}\text{C} \leq T_A \leq +105^{\circ}\text{C}$. Typical values are for $T_A = 25^{\circ}\text{C}$.

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
$I_{Q, VIN}$	Quiescent current	$V = 18\text{ V}, I = 0\text{ A}$	$V_{IN} = 18\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	62	80	μA
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		85	
			$V_{IN} = 12\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	62	80	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		85	
			$V_{IN} = 5\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	59	80	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		85	
			$V_{IN} = 3.3\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	53	80	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		85	
			$V_{IN} = 2.7\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	49	70	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		85	
$I_{SD, VIN}$	Shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}$	$V_{IN} = 18\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	0.5	2.3	μA
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		3.8	
			$V_{IN} = 12\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	0.5	2.3	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		3.8	
			$V_{IN} = 5\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	0.5	2.3	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		3.8	
			$V_{IN} = 3.3\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	0.5	2.3	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		3.8	
			$V_{IN} = 2.7\text{ V}$	$-40^{\circ}\text{C to }+85^{\circ}\text{C}$	0.5	2.3	
				$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		3.8	
$I_{EN/UVLO}$	EN/UVLO pin input leakage current	$V_{IN} = 18\text{ V}, I_{OUT} = 0\text{ A}$	$-40^{\circ}\text{C to }+105^{\circ}\text{C}$			0.1	μA
V_{UVR}	VIN UVLO threshold, rising		$-40^{\circ}\text{C to }+105^{\circ}\text{C}$	2	2.54	2.62	V
V_{UVhyst}	VIN UVLO hysteresis		$-40^{\circ}\text{C to }+105^{\circ}\text{C}$		5%		
V_{ENR}	EN threshold voltage, rising		$-40^{\circ}\text{C to }+105^{\circ}\text{C}$	1.13	1.23	1.3	V
V_{ENF}	EN threshold voltage, falling		$-40^{\circ}\text{C to }+105^{\circ}\text{C}$	1.08	1.13	1.18	V
V_{SHUTF}	EN threshold voltage for low IQ shutdown		$-40^{\circ}\text{C to }+105^{\circ}\text{C}$	0.5	0.75	0.9	V

Electrical Characteristics (continued)

Unless otherwise noted, the specification in the following table applies over the following ambient operating temperature $-40^{\circ}\text{C} \leq T_A \leq +105^{\circ}\text{C}$. Typical values are for $T_A = 25^{\circ}\text{C}$.

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT
R_{ON}	On-resistance	$V_{IN} = 18\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		79	86	mΩ
			-40°C to +85°C			105	
			-40°C to +105°C			115	
		$V_{IN} = 12\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		79	86	
			-40°C to +85°C			105	
			-40°C to +105°C			115	
		$V_{IN} = 9\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		79	86	
			-40°C to +85°C			105	
			-40°C to +105°C			115	
		$V_{IN} = 5\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		79	86	
			-40°C to +85°C			105	
			-40°C to +105°C			115	
		$V_{IN} = 3.3\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		83	92	
			-40°C to +85°C			115	
			-40°C to +105°C			125	
$V_{IN} = 2.7\text{ V}, I_{OUT} = -200\text{ mA}$	25°C		86	95			
	-40°C to +85°C			120			
	-40°C to +105°C			130			
R_{PD}	Output pull down resistance	$V_{IN} = V_{OUT} = 18\text{ V}, V_{EN/UVLO} = 0\text{ V}$	-40°C to +105°C		290	350	Ω
		$V_{IN} = V_{OUT} = 12\text{ V}, V_{EN/UVLO} = 0\text{ V}$	-40°C to +105°C		265	350	
		$V_{IN} = V_{OUT} = 5\text{ V}, V_{EN/UVLO} = 0\text{ V}$	-40°C to +105°C		250	400	
TS	Thermal shutdown	Threshold, $V_{IN} = 18\text{ V}$	-40°C to +105°C		160		°C
TSHDN Hyst	Thermal shutdown hysteresis	TSD hysteresis, $V_{IN} = 18\text{ V}$	-40°C to +105°C		30		°C

7.6 Switching Characteristics

Refer to the timing test circuit in [Figure 16](#) (unless otherwise noted) for references to external components used for the test condition in the switching characteristics table. Switching characteristics shown below are only valid for the power-up sequence where VIN is already in steady state condition before the EN/UVLO pin is asserted high.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IN} = 18 V, V_{EN/UVLO} = 5 V, T_A = 25 °C (unless otherwise noted)						
t _{ON}	Turnon time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		520		μs
t _{OFF}	Turnoff time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		3.3		
t _R	V _{OUT} rise time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		700		
t _F	V _{OUT} fall time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		2		
t _D	Delay time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		180		
V_{IN} = 12 V, V_{EN/UVLO} = 5 V, T_A = 25 °C (unless otherwise noted)						
t _{ON}	Turnon time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		380		μs
t _{OFF}	Turnoff time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		3.3		
t _R	V _{OUT} rise time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		460		
t _F	V _{OUT} fall time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		2		
t _D	ON delay time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		150		
V_{IN} = 3.3 V, V_{EN/UVLO} = 5 V, T_A = 25 °C (unless otherwise noted)						
t _{ON}	Turnon time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		185		μs
t _{OFF}	Turnoff time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		3.3		
t _R	V _{OUT} rise time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		120		
t _F	V _{OUT} fall time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		2		
t _D	ON delay time	R _L = 10 Ω, C _{IN} = 1 μF, C _L = 0.1 μF, CT = 2200 pF		130		

7.7 Typical DC Characteristics

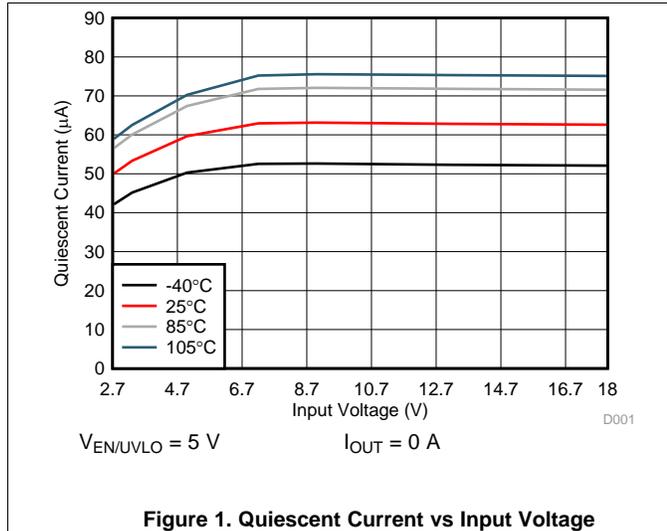


Figure 1. Quiescent Current vs Input Voltage

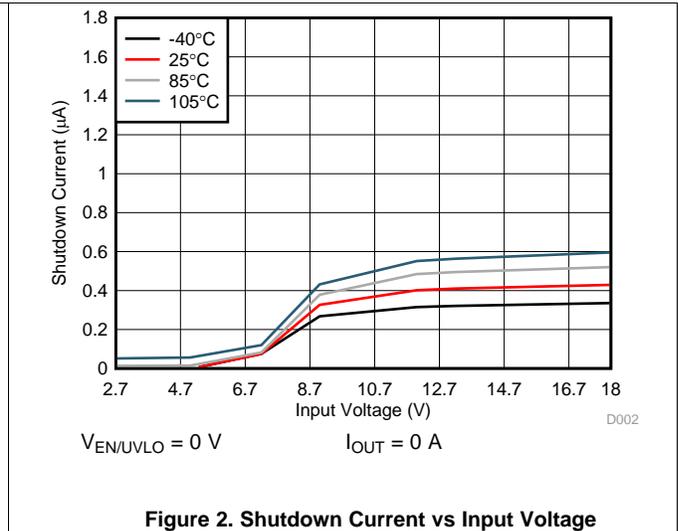


Figure 2. Shutdown Current vs Input Voltage

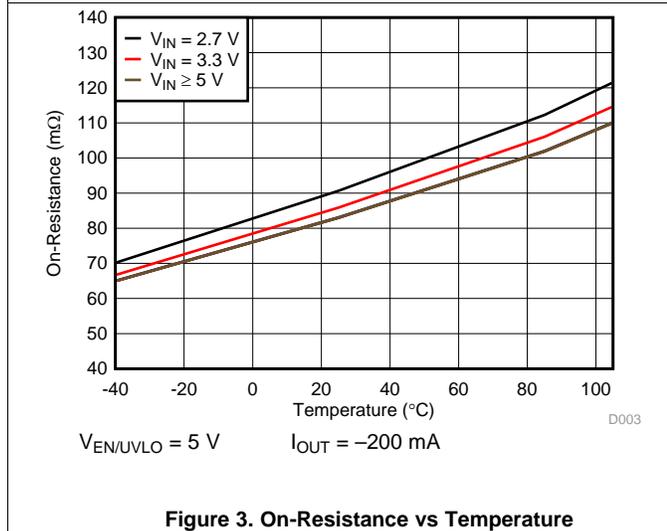


Figure 3. On-Resistance vs Temperature

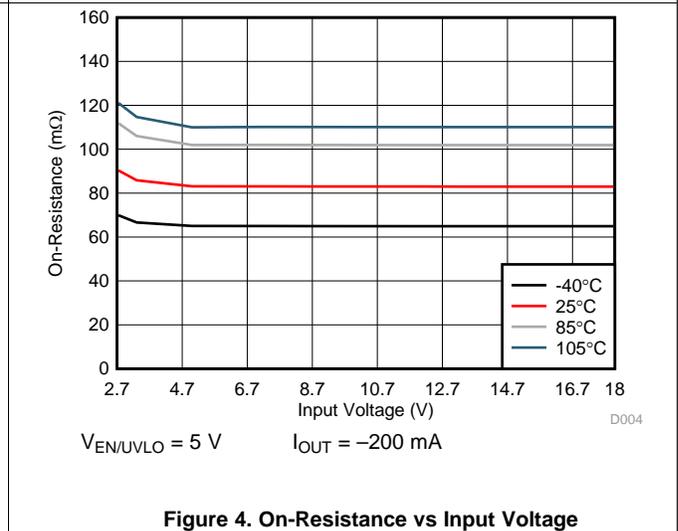


Figure 4. On-Resistance vs Input Voltage

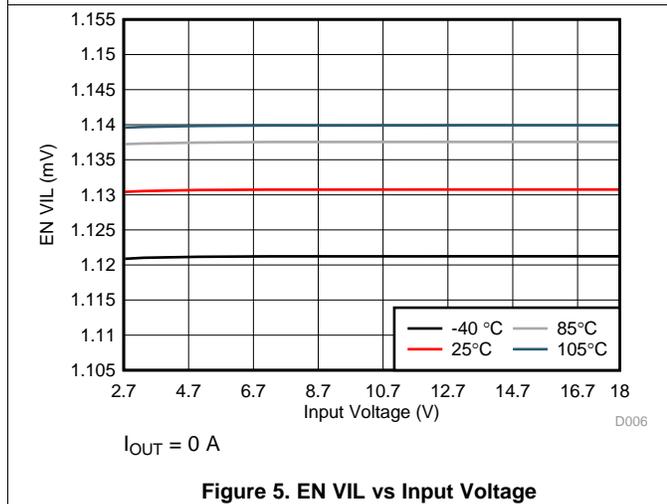


Figure 5. EN VIL vs Input Voltage

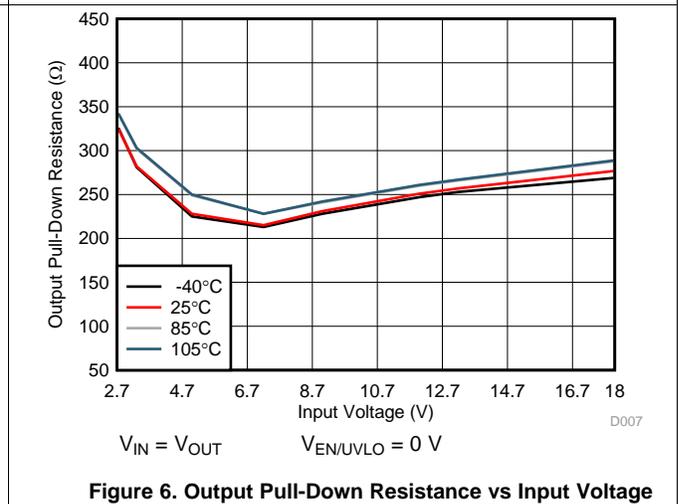


Figure 6. Output Pull-Down Resistance vs Input Voltage

7.8 Typical AC Characteristics

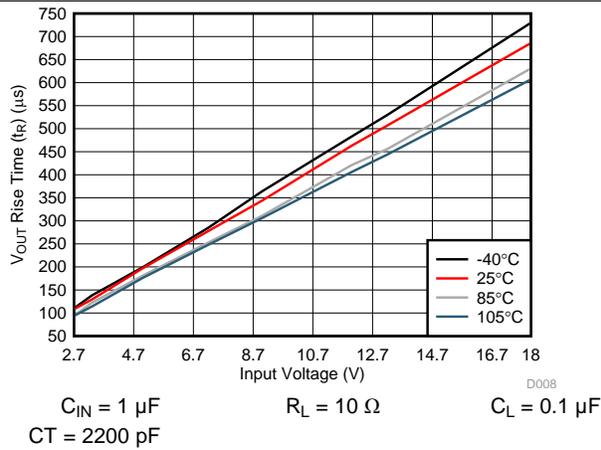


Figure 7. V_{OUT} Rise Time (t_R) vs Input Voltage

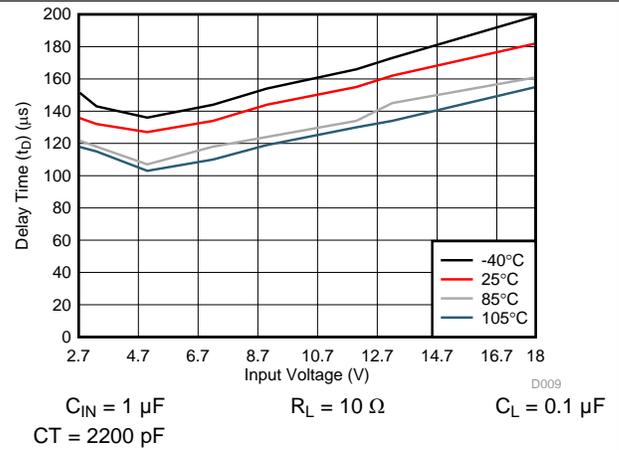


Figure 8. Delay Time (t_D) vs Input Voltage

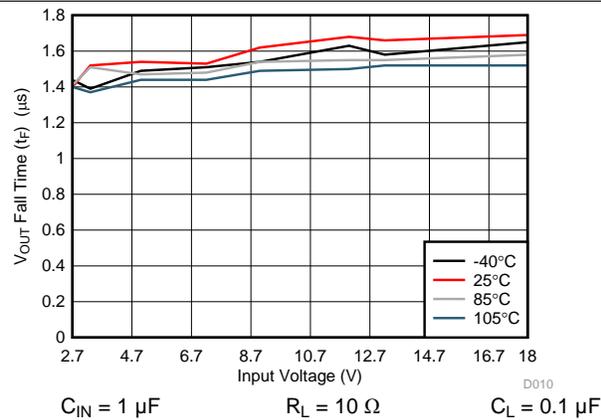


Figure 9. V_{OUT} Fall Time (t_F) vs Input Voltage

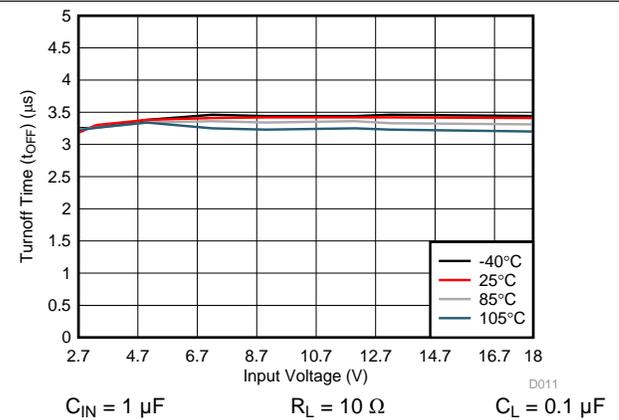


Figure 10. Turnoff Time (t_{OFF}) vs Input Voltage

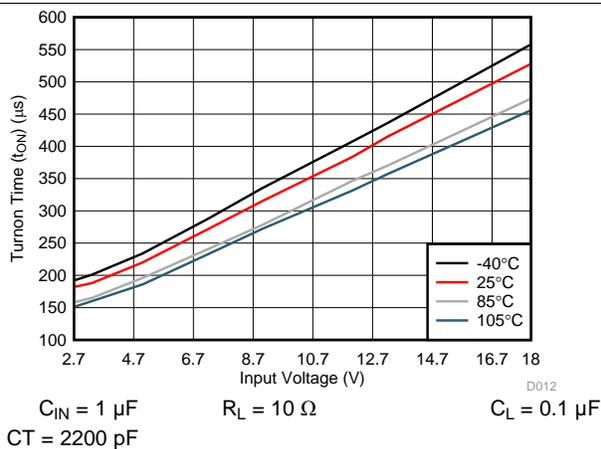


Figure 11. Turnon Time (t_{ON}) vs Input Voltage

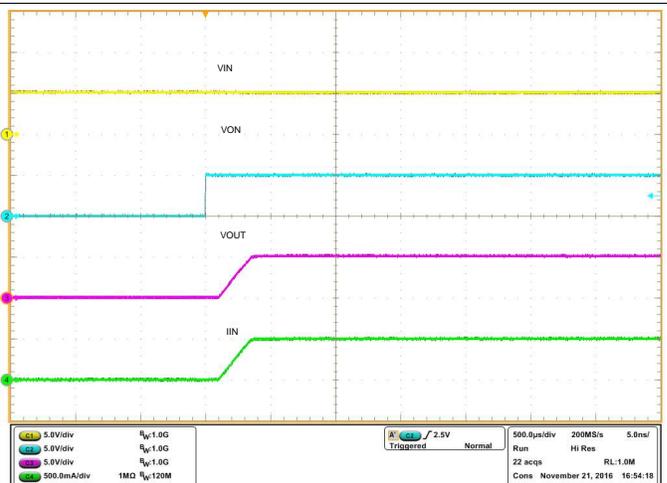
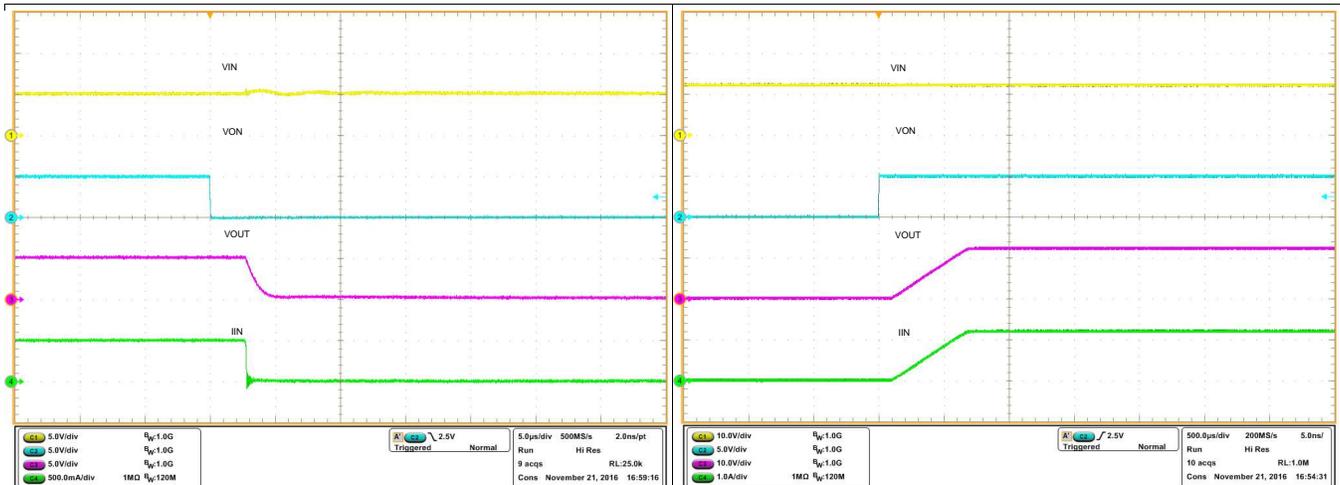


Figure 12. Rise Time t_R at $V_{IN} = 5 V$

Typical AC Characteristics (continued)

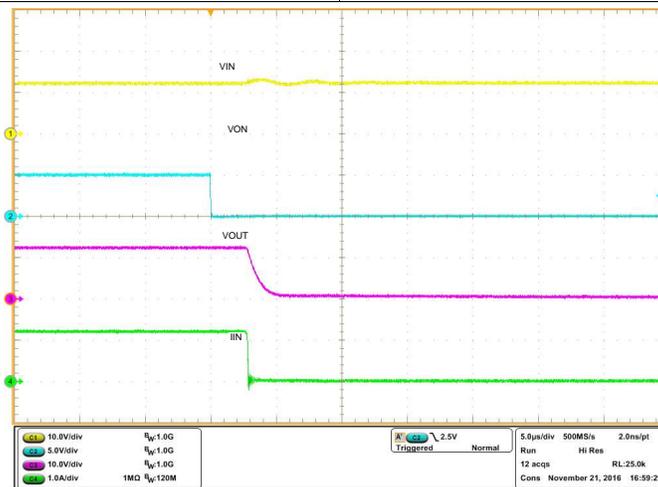


$V_{IN} = 5\text{ V}$ $C_{IN} = 1\text{ }\mu\text{F}$ $C_L = 0.1\text{ }\mu\text{F}$
 $R_L = 10\text{ }\Omega$ QOD = Open

Figure 13. Fall Time t_F at $V_{IN} = 5\text{ V}$

$V_{IN} = 12\text{ V}$ $C_{IN} = 1\text{ }\mu\text{F}$ $C_L = 0.1\text{ }\mu\text{F}$
 $R_L = 10\text{ }\Omega$ CT = 2200 pF

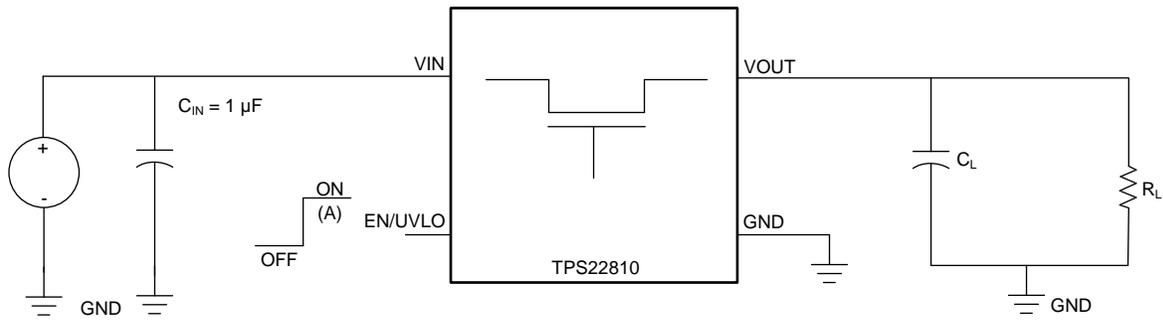
Figure 14. Rise Time t_R at $V_{IN} = 12\text{ V}$



$V_{IN} = 12\text{ V}$ $C_{IN} = 1\text{ }\mu\text{F}$ $C_L = 0.1\text{ }\mu\text{F}$
 $R_L = 10\text{ }\Omega$ QOD = Open

Figure 15. Fall Time t_F at $V_{IN} = 12\text{ V}$

8 Parameter Measurement Information



A. Rise and fall times of the control signal are 100 ns

Figure 16. Test Circuit

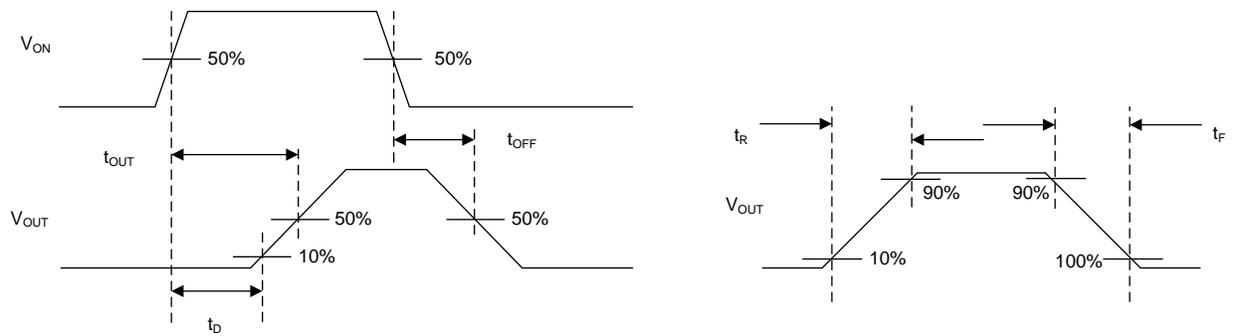


Figure 17. Timing Waveforms

9 Detailed Description

9.1 Overview

The TPS22810 is a 6-pin, 2.7-18-V load switch with thermal protection in two separate package options. To reduce voltage drop for low voltage and high current rails, the device implements a low resistance N-channel MOSFET which reduces the drop out voltage across the device.

The device starts its operation by monitoring the VIN bus. When VIN exceeds the undervoltage-lockout threshold (VUVR), the device samples the EN/UVLO pin. A high level on this pin enables the internal MOSFET. As VIN rises, the internal MOSFET of the device starts conducting and allow current to flow from VIN to VOUT. When EN/UVLO is held low (below VENF), internal MOSFET is turned off.

A voltage $V(\text{EN/UVLO}) < V(\text{ENF})$ on this pin turns off the internal FET, thus disconnecting VIN from VOUT, while voltage below $V(\text{SHUTF})$ takes the device into shutdown mode, with IQ less than 1 μA to ensure minimal power loss.

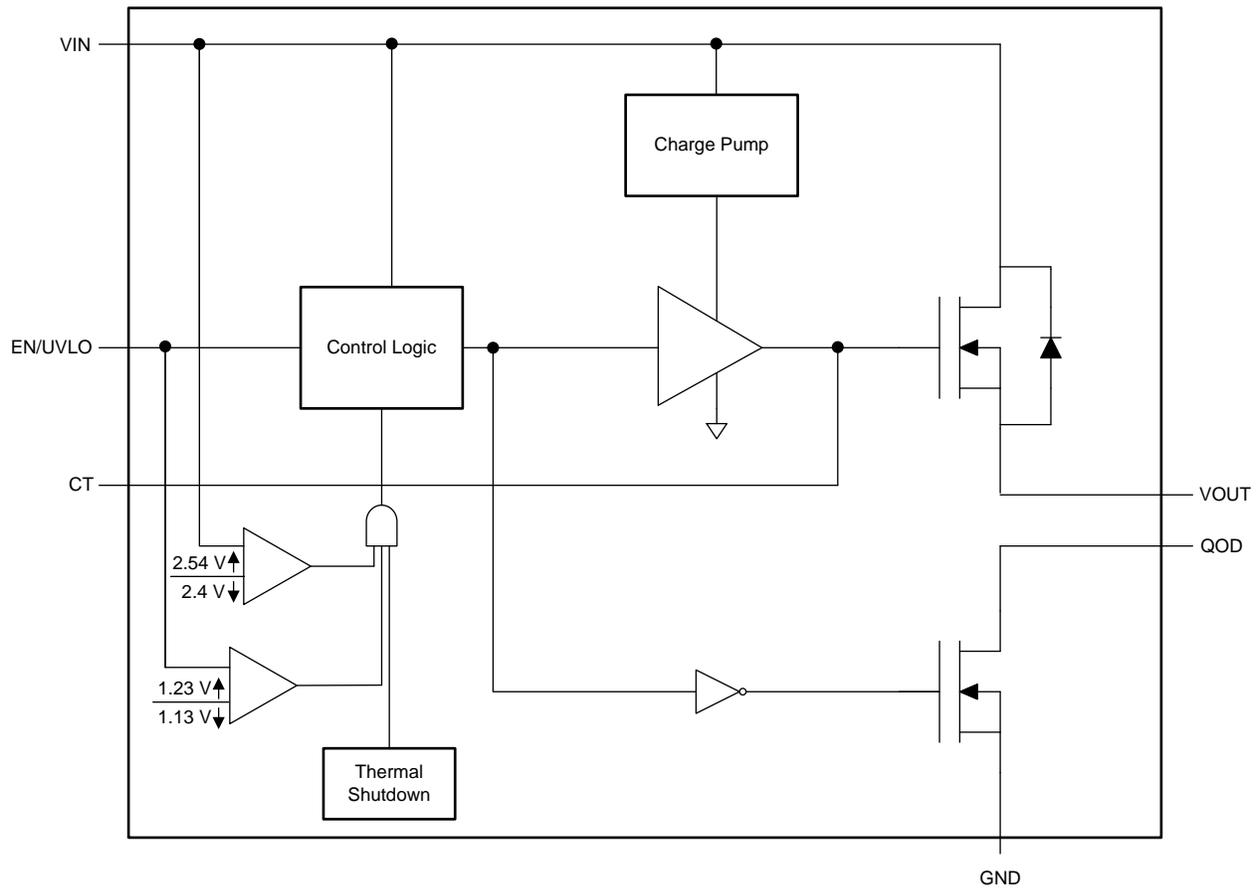
The device has a configurable slew rate which helps reduce or eliminate power supply droop because of large inrush currents. The device also features an internal RPD resistor, which discharges VOUT once the switch is disabled.

During shutdown, the device has very low leakage currents, thereby reducing unnecessary leakages for downstream modules during standby. Integrated control logic, driver, charge pump, and output discharge FET eliminates the need for any external components which reduces solution size and bill of materials (BOM) count.

The device also features a QOD pin, which allows the configuration of the discharge rate of VOUT once the switch is disabled.

The device has a thermal protection feature. Due to this device protects itself against thermal damage due to over-temperature and over-current conditions. Safe Operating Area (SoA) requirements are thus inherently met without any special design consideration by the board designer.

9.2 Functional Block Diagram



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9.3 Feature Description

9.3.1 On and Off Control

The EN/UVLO pin controls the state of the switch. EN/UVLO is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The EN/UVLO pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2 V or higher GPIO voltage. This pin cannot be left floating and must be driven either high or low for proper functionality.

9.3.2 Quick Output Discharge (QOD)

The TPS22810 includes a QOD feature. The QOD pin can be configured in one of three ways:

- QOD pin shorted to VOUT pin. Using this method, the discharge rate after the switch becomes disabled is controlled with the value of the internal resistance R_{PD} . The value of this resistance is listed in the [Electrical Characteristics](#) table.
- QOD pin connected to VOUT pin using an external resistor R_{EXT} . After the switch becomes disabled, the discharge rate is controlled by the value of the total resistance of the QOD. To adjust the total QOD resistance, [Equation 1](#) can be used.

$$R_{QOD} = R_{PD} + R_{EXT}$$

where

- R_{QOD} is the total output discharge resistance
- R_{PD} is the internal pulldown resistance
- R_{EXT} is the external resistance placed between the VOUT and QOD pin.

(1)

Feature Description (continued)

- QOD pin is unused and left floating. Using this method, there is no quick output discharge functionality, and the output remains floating after the switch is disabled.

Note that during thermal shutdown, the QOD functionality is not available. The device does not discharge the load as RPD does not become engaged.

The fall times of the device depend on many factors including the total resistance of the QOD, V_{IN} , and the output capacitance. When QOD is connected to V_{OUT} , the fall time changes over V_{IN} as the internal R_{PD} varies over V_{IN} . To calculate the approximate fall time of V_{OUT} for a given R_{QOD} , use Equation 2 and Table 1.

$$V_{CAP} = V_{IN} \times e^{-t/\tau}$$

where

- V_{CAP} is the voltage across the capacitor (V)
- t is the time since power supply removal (s)
- τ is the time constant equal to $R_{QOD} \times C_L$ (2)

The fall times' dependency on V_{IN} becomes minimal as the QOD value increases with additional external resistance. See Table 1 for QOD fall times.

Table 1. QOD Fall Times

V_{IN} (V)	FALL TIME (μ s) 90% - 10%, $C_{IN} = 1 \mu$ F, $I_{OUT} = 0$ A, $V_{IN} = 0$ V, ON = 0 V ⁽¹⁾					
	$T_A = 25^\circ$ C			$T_A = 85^\circ$ C		
	$C_L = 1 \mu$ F	$C_L = 10 \mu$ F	$C_L = 100 \mu$ F	$C_L = 1 \mu$ F	$C_L = 10 \mu$ F	$C_L = 100 \mu$ F
18	470	4700	47000	470	4700	47000
12	450	4500	45000	450	4500	45000
9	440	4400	44000	440	4400	44000
5	500	5000	50000	480	4800	48000
3.3	600	6000	60000	570	5700	57000

(1) TYPICAL VALUES WITH QOD SHORTED TO V_{OUT}

9.3.2.1 QOD when System Power is Removed

The adjustable QOD can be used to control the power down sequencing of a system even when the system power supply is removed. When the power is removed, the input capacitor, C_{IN} , discharges at V_{IN} . Past the set UVLO level, the pull-down resistance RPD becomes disabled and the output no longer becomes discharged. If there is still remaining charge on the output capacitor, this results in longer fall times. Care must be taken such that C_{IN} is large enough to meet the device UVLO settings.

9.3.2.2 Internal QOD Considerations

Special considerations must be taken when using the internal R_{PD} by shorting the QOD pin to the V_{OUT} pin. The internal R_{PD} is a pulldown resistance designed to quickly discharge a load after the switch has been disabled. Care must be used to ensure that excessive current does not flow through R_{PD} during discharge so that the maximum T_J of 125° C is not exceeded. When using only the internal R_{PD} to discharge a load, the total capacitive load must not exceed 200 μ F. Otherwise, an external resistor, R_{EXT} , must be used to ensure the amount of current flowing through R_{PD} is properly limited and the maximum T_J is not exceeded. To ensure the device is not damaged, the remaining charge from C_L needs to decay naturally through the internal QOD resistance and must not be driven.

9.3.3 EN/UVLO

As an input pin, EN/UVLO controls the ON and OFF state of the internal MOSFET. In its high state, the internal MOSFET is enabled. A low on this pin turns off the internal MOSFET. High and Low levels are specified in the parametric table of the datasheet

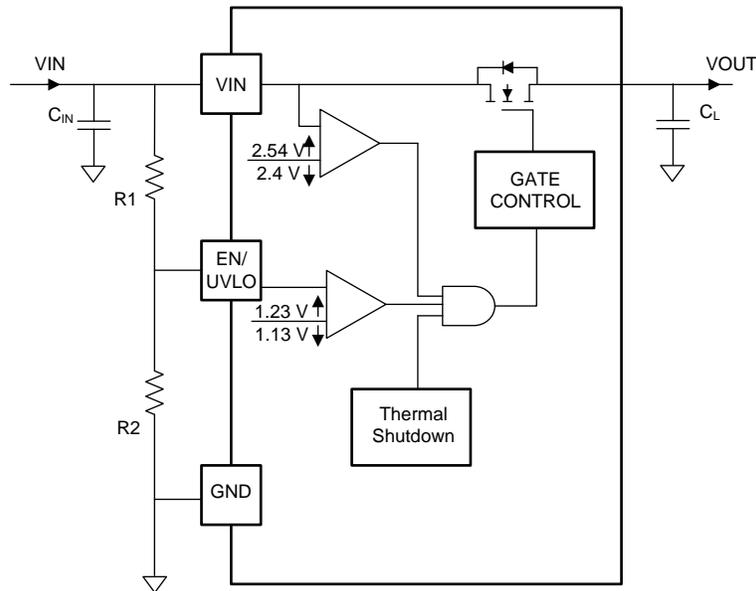
A voltage $V(EN/UVLO < V(ENF))$ on this pin turns off the internal FET, thus disconnecting V_{IN} from V_{OUT} , while voltage below $V(SHUTF)$ takes the device into shutdown mode, with I_Q less than 1 μ A to ensure minimal power loss.

The EN/UVLO pin can be directly driven by a 1.8 V, 3.3 V or 5 V general purpose output pin.

The internal de-glitch delay on EN/UVLO falling edge is intentionally kept low (2.5 μ s typical) for quick detection of power failure. For applications where a higher de-glitch delay on EN/UVLO is desired, or when the supply is particularly noisy, it is recommended to use an external bypass capacitor from EN/UVLO to GND.

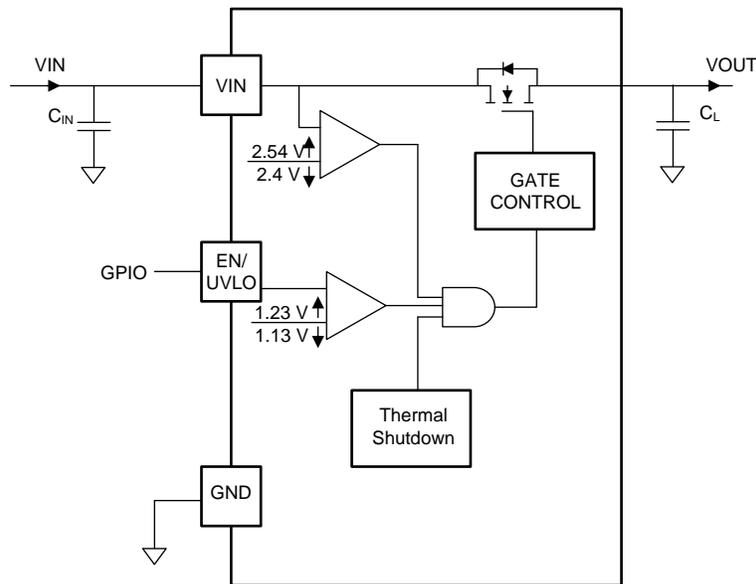
The undervoltage lock out can be programmed by using an external resistor divider from supply VIN terminal to EN/UVLO terminal to GND as shown in Figure 18. When an undervoltage or input power fail event is detected, the internal FET is quickly turned off. If the Under-Voltage Lock-Out function is not needed, the EN/UVLO terminal must be connected to the VIN terminal. EN/UVLO terminal must not be left floating.

The device also implements internal undervoltage-lockout (UVLO) circuitry on the VIN terminal. The device disables when the VIN terminal voltage falls below internal UVLO Threshold V(UVF). The internal UVLO threshold has a hysteresis of 125 mV (5% of V(UVR)). See Figure 19 and Figure 20.



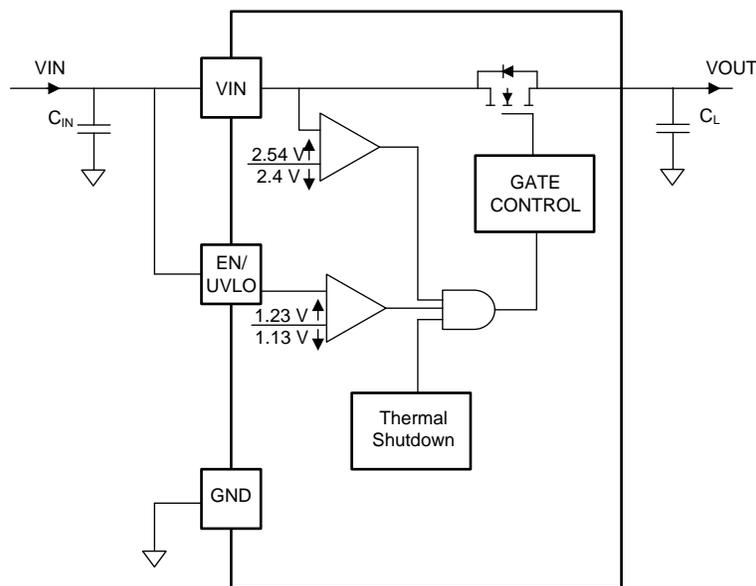
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Figure 18. Configuring UVLO with External Resistor Network



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Figure 19. Using 1.8 V/3.3 V GPIO Signal Directly from Processor



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Figure 20. Default UVLO Threshold V(UVR) Using No Additional External Components

9.3.4 Adjustable Rise Time (CT)

A capacitor to GND on the CT pin sets the slew rate. The voltage on the CT pin can be as high as 2.5 V. An approximate formula for the relationship between CT and slew rate is shown in Equation 3. This equation accounts for 10% to 90% measurement on VOUT and does NOT apply for CT < 1 nF.

Use Table 2 to determine rise times for when Ct ≥ 1 nF.

$$SR = 46.62 / Ct$$

where

- SR is the slew rate (in V/μs)

- CT is the the capacitance value on the CT pin (in pF)
- The units for the constant a are $\mu\text{s}/\text{V}$. The units for the constant b are $\mu\text{s}/(\text{V} \times \text{pF})$. (3)

Rise time can be calculated by dividing the input voltage by the slew rate. [Table 2](#) contains rise time values measured on a typical device. Rise times shown below are only valid for the power-up sequence where VIN is already in steady state condition before the EN/UVLO pin is asserted high.

Table 2. Rise Time Table

CT (pF)	RISE TIME (μs) 10% - 90%, $C_L = 0.1 \mu\text{F}$, $C_{IN} = 1 \mu\text{F}$, $R_L = 10 \Omega$				
	VIN = 18 V	VIN = 12 V	VIN = 9 V	VIN = 5 V	VIN = 3.3 V
0	115	91	78	60	98
470	136	94	80	63	98
1000	310	209	158	91	102
2200	688	464	345	198	135
4700	1430	957	704	397	265
10000	3115	2085	1540	864	550
27000	8230	5460	4010	2245	1430

9.3.5 Thermal Shutdown

The switch disables when the junction temperature (T_J) rises above the thermal shutdown threshold, T_{SD} . The switch re-enables once the temperature drops below the $T_{SD} - T_{SD,HYS}$ value.

9.4 Device Functional Modes

The features of the TPS22810 depend on the operating mode. [Table 3](#) summarizes the Device Functional Modes.

Table 3. Function Table

EN/UVLO	Device State
L	Disabled
H	Enabled

10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

This section highlights some of the design considerations when implementing this device in various applications. A PSPICE model for this device is also available in the product page of this device on www.ti.com (See the [デバイス・サポート](#) section for more information).

10.2 ON and OFF Control

The EN/UVLO pin controls the state of the switch. Asserting EN/UVLO high enables the switch. EN/UVLO is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The EN/UVLO pin is compatible with standard GPIO logic thresholds. It can be used with any microcontroller with 1.2 V or higher GPIO voltage. This pin cannot be left floating and must be driven either high or low for proper functionality.

10.3 Input Capacitor (Optional)

To limit the voltage drop on the input supply caused by transient inrush currents when the switch turns on into a discharged load capacitor, a capacitor needs to be placed between VIN and GND. A 1- μ F ceramic capacitor, C_{IN} , placed close to the pins, is usually sufficient. Higher values of C_{IN} can be used to further reduce the voltage drop during high current applications. When switching heavy loads, it is recommended to have an input capacitor about 10 times higher than the output capacitor to avoid excessive voltage drop.

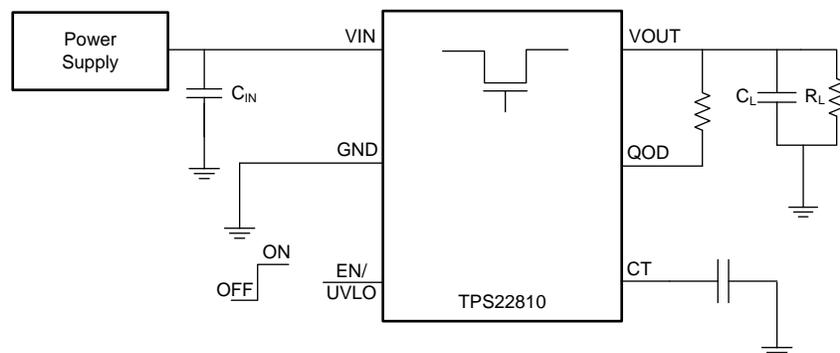
10.4 Output Capacitor (Optional)

Due to the integrated body diode in the NMOS switch, a C_{IN} greater than C_L is highly recommended. A C_L greater than C_{IN} can cause VOUT to exceed VIN when the system supply is removed. This can result in current flow through the body diode from VOUT to VIN. A C_{IN} to C_L ratio of 10 to 1 is recommended for minimizing VIN dip caused by inrush currents during startup; however, a 10 to 1 ratio for capacitance is not required for proper functionality of the device. A ratio smaller than 10 to 1 (such as 1 to 1) can cause slightly more VIN dip upon turnon due to inrush currents.

This can be mitigated by increasing the capacitance on the CT pin for a longer rise time.

10.5 Typical Application

This typical application demonstrates how the TPS22810 can be used to power downstream modules.



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Figure 21. Typical Application Schematic

Typical Application (continued)

10.5.1 Design Requirements

For this design example, use the values listed in [Table 4](#) as the design parameters:

Table 4. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
V_{IN}	12 V
Load current	2 A
C_L	22 μ F
Desired fall time	20 ms
Maximum acceptable inrush current	400 mA

10.5.2 Detailed Design Procedure

10.5.2.1 Shutdown Sequencing During Unexpected Power Loss

Using the adjustable Quick Output Discharge function of the TPS22810, adding a load switch to each power rail can be used to manage the power down sequencing in the event of an unexpected power loss (that is battery removal). To determine the QOD values for each load switch, first confirm the power down order of the device you wish to power sequence. Be sure to check if there are voltage or timing margins that must be maintained during power down. Next, consult [Table 1](#) to determine appropriate C_L and R_{QOD} values for each power rail's load switch so that the load switches' fall times correspond to the order in which they need to be powered down. In the above example, we must have this power rail's fall time to be 4 ms. Using [Equation 2](#), we can determine the appropriate R_{QOD} to achieve our desired fall time.

Since fall times are measured from 90% of V_{OUT} to 10% of V_{OUT} , using [Equation 2](#), we get [Equation 4](#) and [Equation 5](#).

$$1.2V = 10.8V \times e^{-(20ms)/(R_{QOD} \times (22\mu F))} \quad (4)$$

$$R_{QOD} = 413.7 \Omega \quad (5)$$

Consulting [Figure 6](#), R_{PD} at $V_{IN} = 12$ V is approximately 250 Ω . Using [Equation 1](#), the required external QOD resistance can be calculated as shown in [Equation 6](#) and [Equation 7](#).

$$413.7 \Omega = 250 \Omega + R_{EXT} \quad (6)$$

$$R_{EXT} = 163.7 \Omega \quad (7)$$

[Figure 22](#) through [Figure 25](#) are scope shots demonstrating an example of the QOD functionality when power is removed from the device (both ON and VIN are disconnected simultaneously). In the scope shots, the $V_{IN} = 12$ V and correspond to when $R_{QOD} = 1000 \Omega$, $R_{QOD} = 500 \Omega$, and QOD = VOUT with two values of $C_L = 10 \mu$ F and 22 μ F.

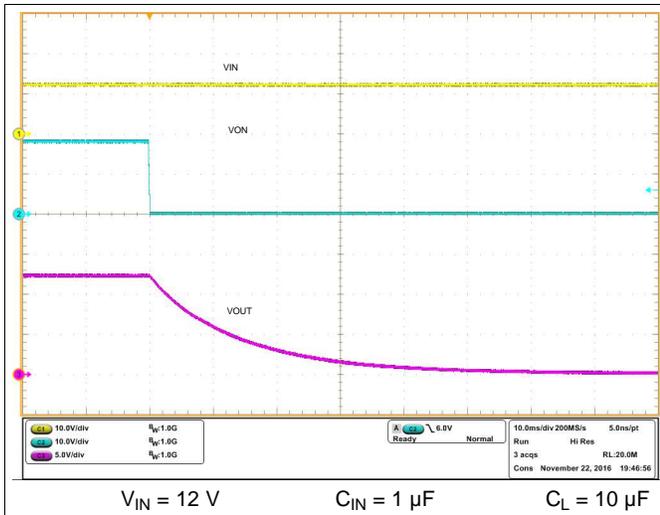


Figure 22. Fall Time t_F at $V_{IN} = 12\text{ V}$, $R_{QOD} = 1000\ \Omega$

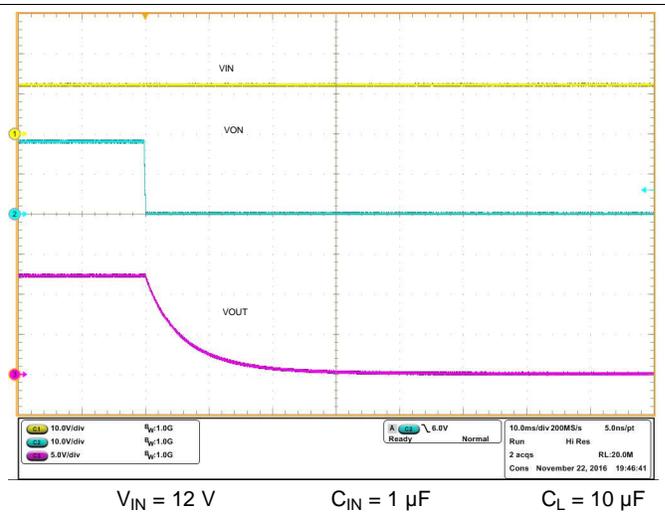


Figure 23. Fall Time t_F at $V_{IN} = 12\text{ V}$, $R_{QOD} = 500\ \Omega$

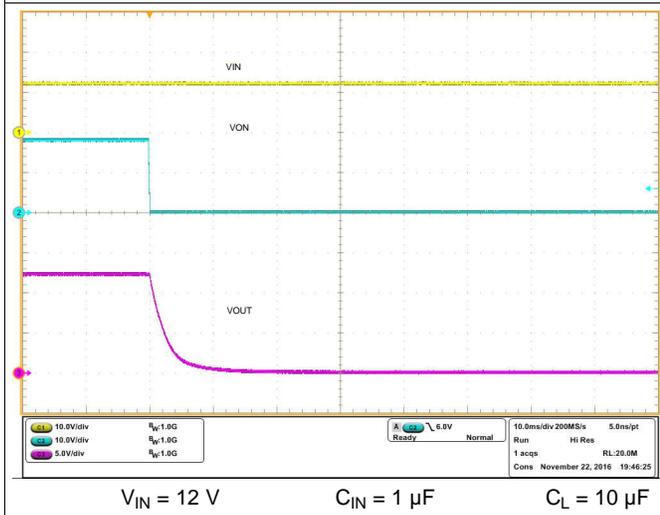


Figure 24. t_F at $V_{IN} = 12\text{ V}$, $QOD = V_{OUT}$

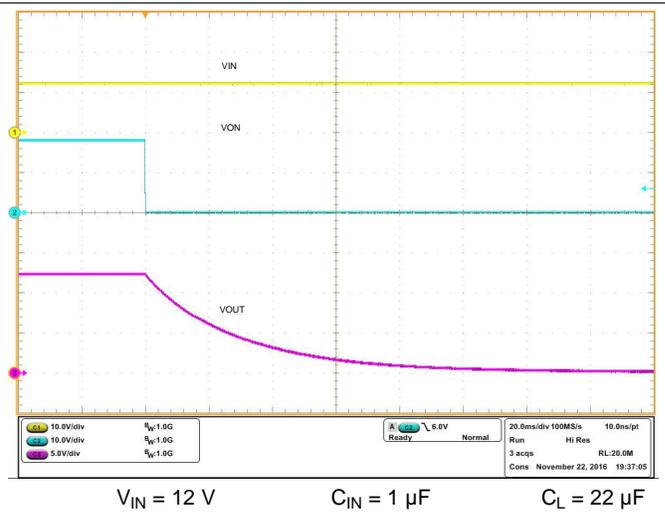


Figure 25. t_F at $V_{IN} = 12\text{ V}$, $R_{QOD} = 1000\ \Omega$

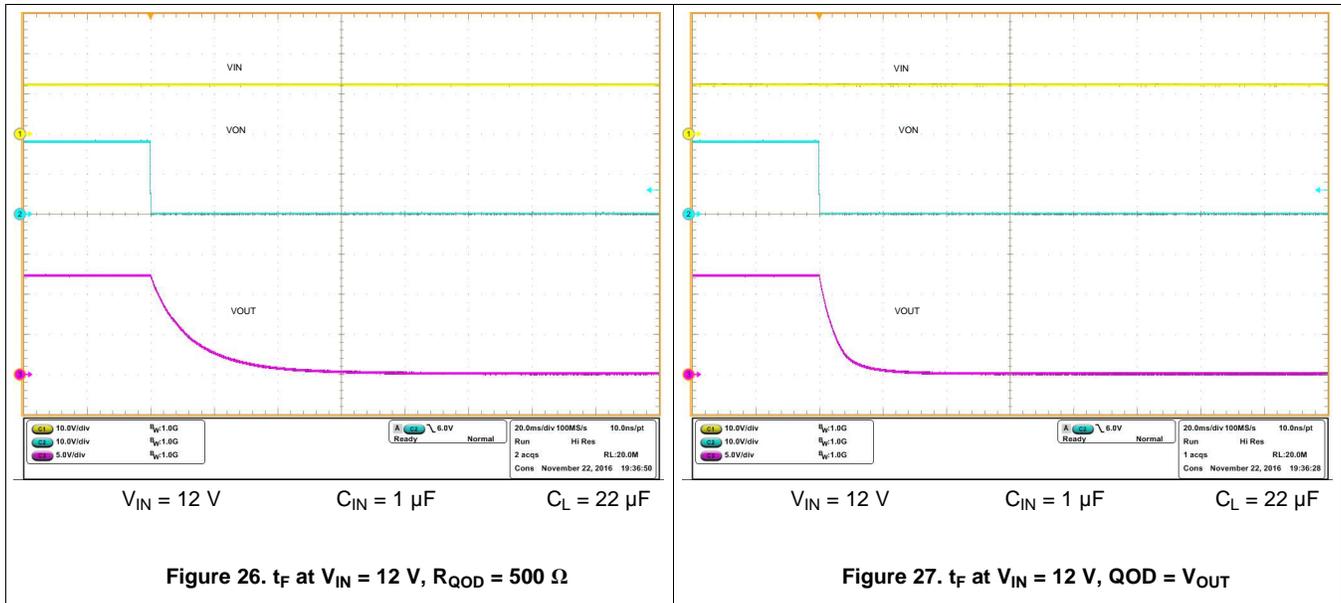


Figure 26. t_F at $V_{IN} = 12\text{ V}$, $R_{QOD} = 500\ \Omega$

Figure 27. t_F at $V_{IN} = 12\text{ V}$, $Q_{OD} = V_{OUT}$

10.5.2.2 VIN to VOUT Voltage Drop

The V_{IN} to V_{OUT} voltage drop in the device is determined by the R_{ON} of the device and the load current. The R_{ON} of the device depends upon the V_{IN} conditions of the device. Refer to the R_{ON} specification of the device in the [Electrical Characteristics](#) table of this datasheet. Once the R_{ON} of the device is determined based upon the V_{IN} conditions, use [Equation 8](#) to calculate the V_{IN} to V_{OUT} voltage drop.

$$\Delta V = I_{LOAD} \times R_{ON}$$

where

- ΔV is the voltage drop from V_{IN} to V_{OUT}
- I_{LOAD} is the load current
- R_{ON} is the On-resistance of the device for a specific V_{IN}

(8)

An appropriate I_{LOAD} must be chosen such that the I_{MAX} specification of the device is not violated.

10.5.2.3 Inrush Current

To determine how much inrush current is caused by the C_L capacitor, use [Equation 9](#).

$$I_{INRUSH} = C_L \times \frac{dV_{OUT}}{dt}$$

where

- I_{INRUSH} is the amount of inrush caused by C_L
- C_L is the capacitance on V_{OUT}
- dt is the Output Voltage rise time during the ramp up of V_{OUT} when the device is enabled
- dV_{OUT} is the change in V_{OUT} during the ramp up of V_{OUT} when the device is enabled

(9)

The appropriate rise time can be calculated using the design requirements and the inrush current equation. As we calculate the rise time (measured from 10% to 90% of V_{OUT}), we account for this in our dV_{OUT} parameter (80% of $V_{OUT} = 9.6\text{ V}$) as shown in [Equation 10](#) and [Equation 11](#).

$$400\text{ mA} = 22\ \mu\text{F} \times 9.6\text{ V}/dt \tag{10}$$

$$dt = 528\ \mu\text{s} \tag{11}$$

To ensure an inrush current of less than 400 mA, choose a C_T value that yields a rise time of more than 528 μs . Consulting [Table 2](#) at $V_{IN} = 12\text{ V}$, $C_T = 4700\text{ pF}$ provides a typical rise time of 957 μs . Using this rise time and voltage into [Equation 9](#), yields [Equation 12](#) and [Equation 13](#).

$$I_{Inrush} = 22\ \mu\text{F} \times 9.6\text{ V}/957\ \mu\text{s} \tag{12}$$

$$I_{Inrush} = 220\text{ mA} \tag{13}$$

An appropriate C_L value must be placed on VOUT such that the I_{MAX} and I_{PLS} specifications of the device are not violated.

10.5.3 Application Curves

See the oscilloscope captures below for an example of how the CT capacitor can be used to reduce inrush current for $V_{IN} = 12\text{ V}$. See the [Adjustable Rise Time \(CT\)](#) section for rise times for corresponding CT values.

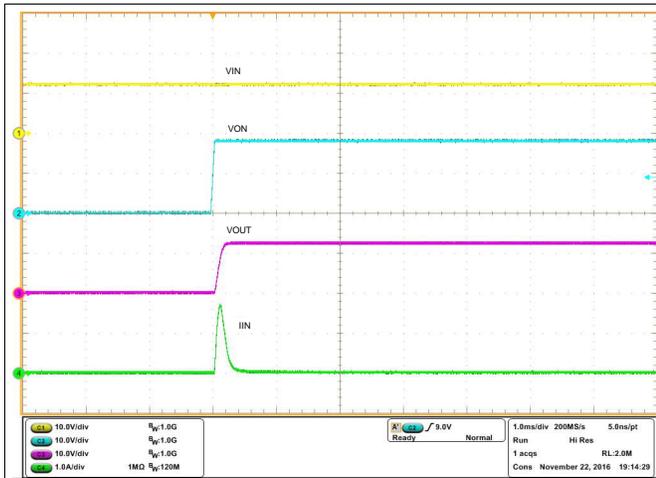


Figure 28. TPS22810 Inrush Current With $C_L = 22\ \mu\text{F}$, $CT = 0\ \text{pF}$

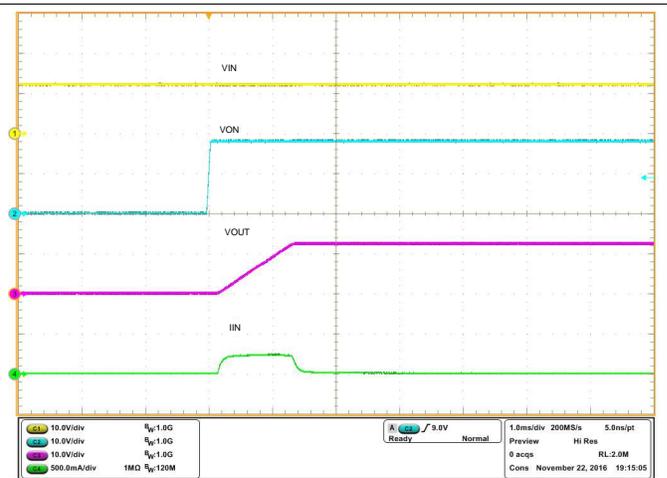


Figure 29. TPS22810 Inrush Current with $C_L = 22\ \mu\text{F}$, $CT = 4700\ \text{pF}$

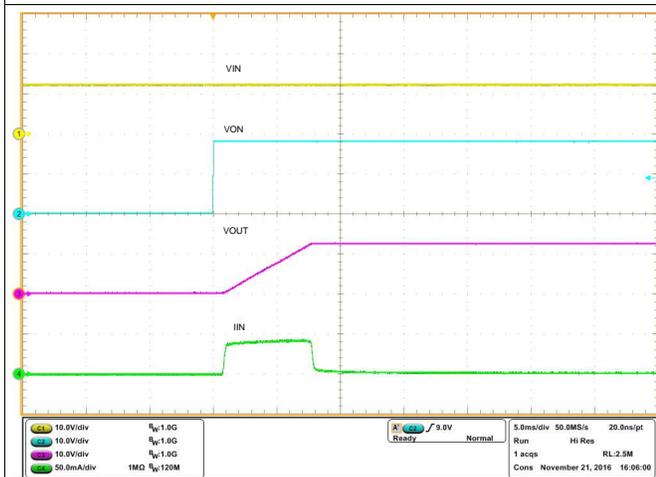


Figure 30. TPS22810 Inrush Current With $C_L = 22\ \mu\text{F}$, $CT = 27000\ \text{pF}$

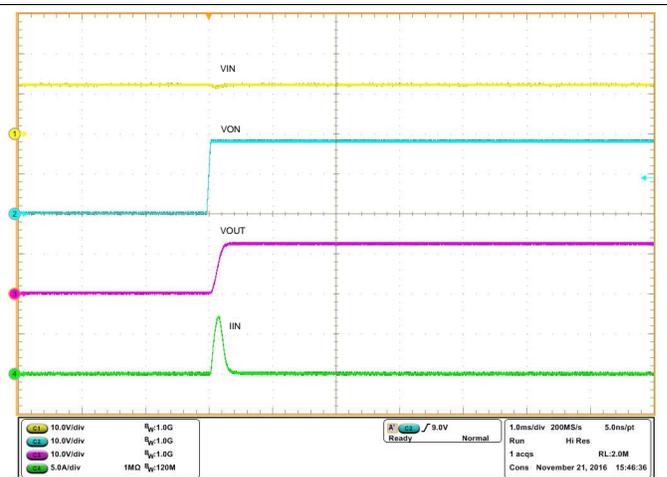
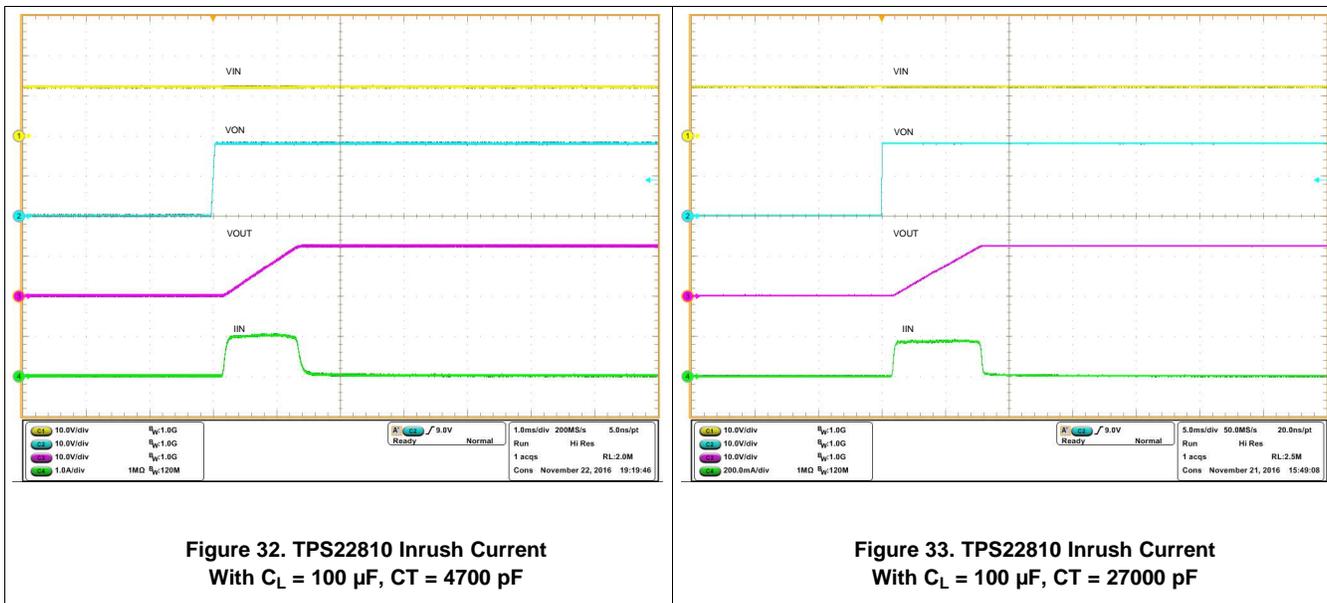


Figure 31. TPS22810 Inrush Current With $C_L = 100\ \mu\text{F}$, $CT = 0\ \text{pF}$



11 Power Supply Recommendations

The device is designed to operate from a V_{IN} range of 2.7 V to 18 V. This supply must be well regulated and placed as close to the device terminal as possible with the recommended 1- μF bypass capacitor. If the supply is located more than a few inches from the device terminals, additional bulk capacitance may be required in addition to the ceramic bypass capacitors. If additional bulk capacitance is required, an electrolytic, tantalum, or ceramic capacitor of 1 μF may be sufficient.

The TPS22810 operates regardless of power sequencing order. The order in which voltages are applied to V_{IN} and ON does not damage the device as long as the voltages do not exceed the absolute maximum operating conditions.

12 Layout

12.1 Layout Guidelines

- VIN and VOUT traces must be as short and wide as possible to accommodate for high current.
- The VIN pin must be bypassed to ground with low ESR ceramic bypass capacitors. The typical recommended bypass capacitance is 1- μ F ceramic with X5R or X7R dielectric. This capacitor must be placed as close to the device pins as possible.

12.2 Layout Example

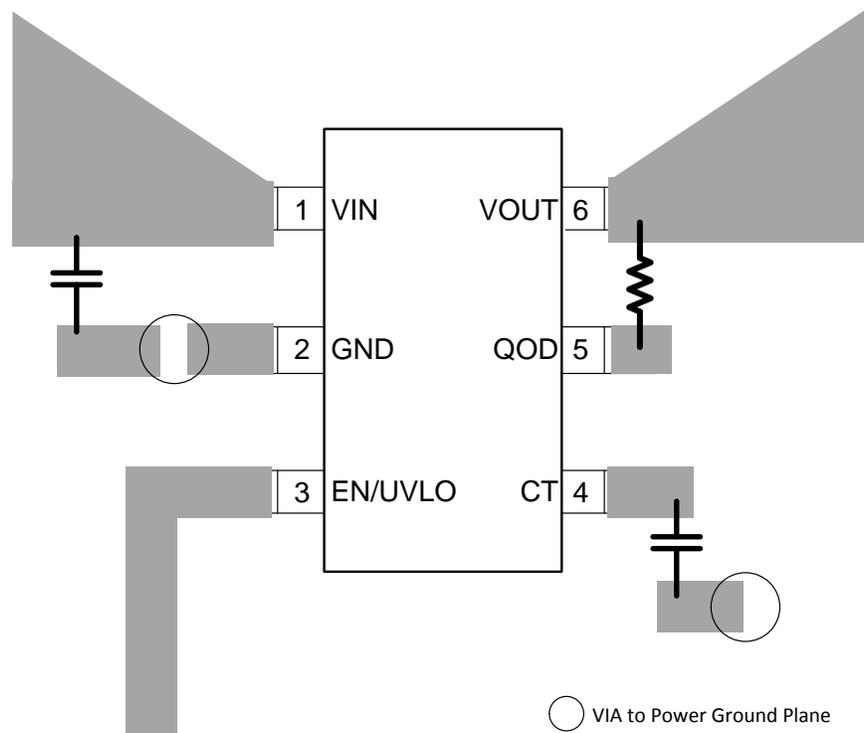


Figure 34. Recommended Board Layout

12.3 Thermal Considerations

For best performance, all traces must be as short as possible. To be most effective, the input and output capacitors must be placed close to the device to minimize the effects that parasitic trace inductances may have on normal and short-circuit operation. Using wide traces for VIN, VOUT, and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

The maximum IC junction temperature must be restricted to 150°C under normal operating conditions. To calculate the maximum allowable dissipation, $P_{D(\max)}$ for a given output current and ambient temperature, use [Equation 14](#).

$$P_{D(\max)} = \frac{T_{J(\max)} - T_A}{\theta_{JA}}$$

where

- $P_{D(\max)}$ is the maximum allowable power dissipation
- $T_{J(\max)}$ is the maximum allowable junction temperature (150°C for the TPS22810)
- T_A is the ambient temperature of the device
- θ_{JA} is the junction to air thermal impedance. Refer to the [Thermal Information](#) table. This parameter is highly dependent upon board layout. (14)

13 デバイスおよびドキュメントのサポート

13.1 デバイス・サポート

13.1.1 開発サポート

TPS22810 PSpiceトランジェント・モデルについては、『[TPS22810 PSpiceトランジェント・モデル](#)』を参照してください。

13.2 ドキュメントのサポート

13.2.1 関連資料

関連資料については、以下を参照してください。

- 『[TPS22810負荷スイッチ評価モジュール](#)』
- 『[ディスクリート・ソリューションに置き換わる負荷スイッチの選択](#)』
- 『[負荷スイッチのタイミング](#)』

13.3 ドキュメントの更新通知を受け取る方法

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13.4 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™オンライン・コミュニティ *TIのE2E (Engineer-to-Engineer)* コミュニティ。エンジニア間の共同作業を促進するために開設されたものです。e2e.ti.comでは、他のエンジニアに質問し、知識を共有し、アイデアを検討して、問題解決に役立てることができます。

設計サポート *TIの設計サポート* 役に立つE2Eフォーラムや、設計サポート・ツールをすばやく見つけることができます。技術サポート用の連絡先情報も参照できます。

13.5 商標

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

13.6 静電気放電に関する注意事項



すべての集積回路は、適切なESD保護方法を用いて、取扱いと保存を行うようにして下さい。

静電気放電はわずかな性能の低下から完全なデバイスの故障に至るまで、様々な損傷を与えます。高精度の集積回路は、損傷に対して敏感であり、極めてわずかなパラメータの変化により、デバイスに規定された仕様に適合しなくなる場合があります。

13.7 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS22810DBVR	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DBVR.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DBVRG4	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DBVRG4.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DBVT	Active	Production	SOT-23 (DBV) 6	250 SMALL T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DBVT.A	Active	Production	SOT-23 (DBV) 6	250 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 105	19HF
TPS22810DRVR	Active	Production	WSON (DRV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH
TPS22810DRVR.A	Active	Production	WSON (DRV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH
TPS22810DRVRG4	Active	Production	WSON (DRV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH
TPS22810DRVRG4.A	Active	Production	WSON (DRV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH
TPS22810DRVT	Active	Production	WSON (DRV) 6	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH
TPS22810DRVT.A	Active	Production	WSON (DRV) 6	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	1CRH

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TPS22810 :

- Automotive : [TPS22810-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS22810DBVR	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TPS22810DBVRG4	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TPS22810DBVT	SOT-23	DBV	6	250	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TPS22810DRVR	WSON	DRV	6	3000	178.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
TPS22810DRVRG4	WSON	DRV	6	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2
TPS22810DRVT	WSON	DRV	6	250	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

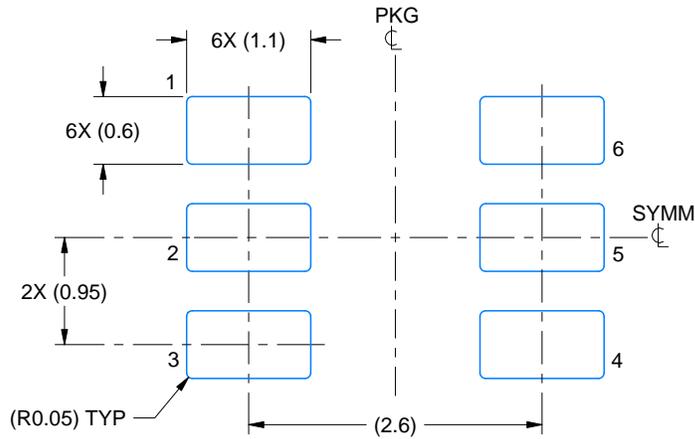
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS22810DBVR	SOT-23	DBV	6	3000	210.0	185.0	35.0
TPS22810DBVRG4	SOT-23	DBV	6	3000	210.0	185.0	35.0
TPS22810DBVT	SOT-23	DBV	6	250	210.0	185.0	35.0
TPS22810DRVR	WSON	DRV	6	3000	208.0	191.0	35.0
TPS22810DRVRG4	WSON	DRV	6	3000	210.0	185.0	35.0
TPS22810DRVT	WSON	DRV	6	250	210.0	185.0	35.0

EXAMPLE BOARD LAYOUT

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214840/G 08/2024

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

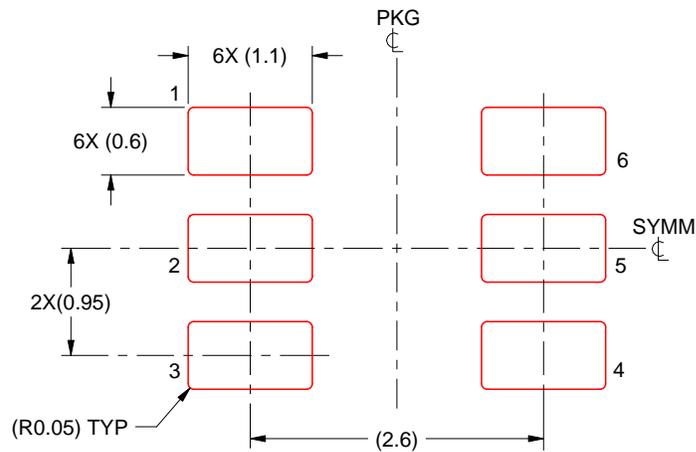
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214840/G 08/2024

NOTES: (continued)

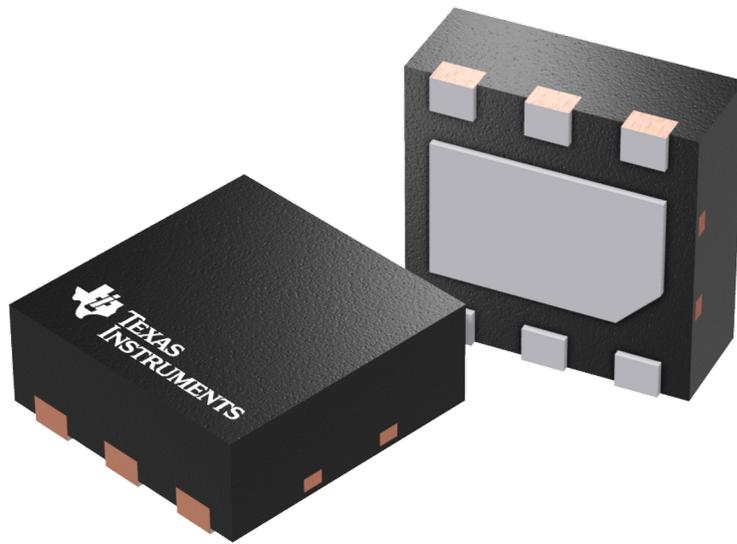
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

DRV 6

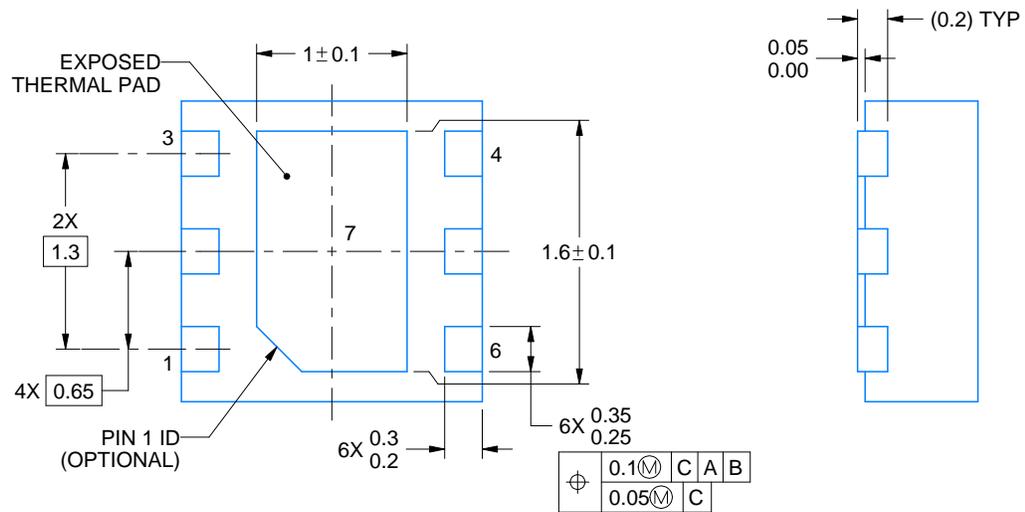
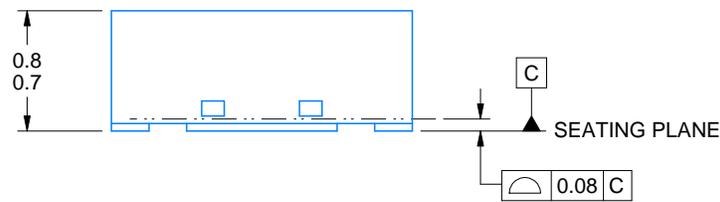
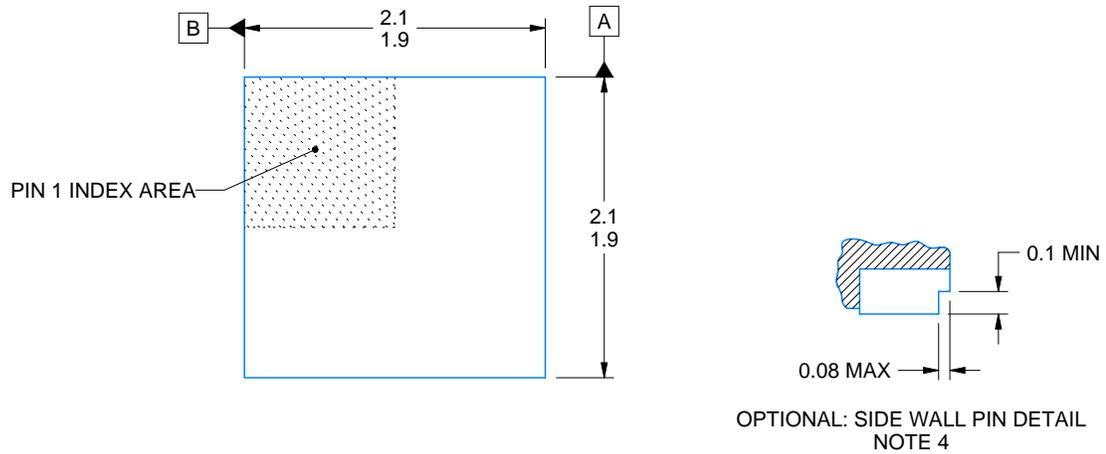
WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4206925/F



4222173/C 11/2025

NOTES:

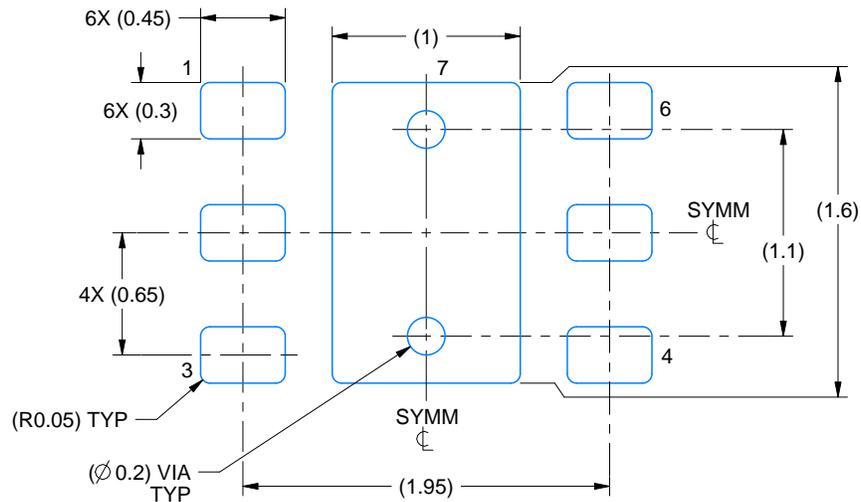
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
4. Minimum 0.1 mm solder wetting on pin side wall. Available for wettable flank version only.

EXAMPLE BOARD LAYOUT

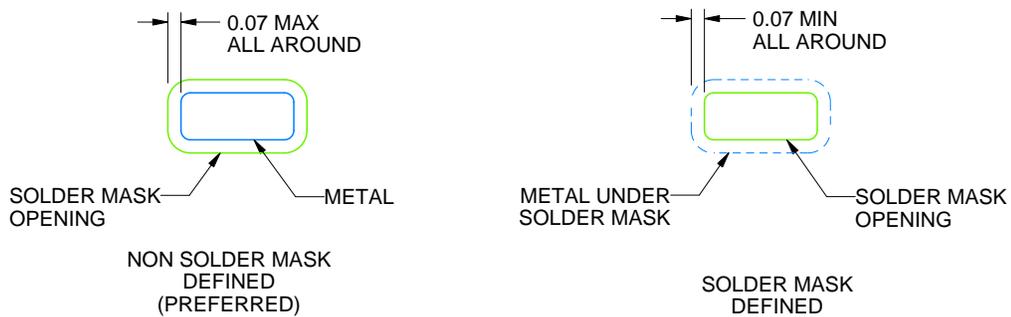
DRV0006A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
SCALE:25X



SOLDER MASK DETAILS

4222173/C 11/2025

NOTES: (continued)

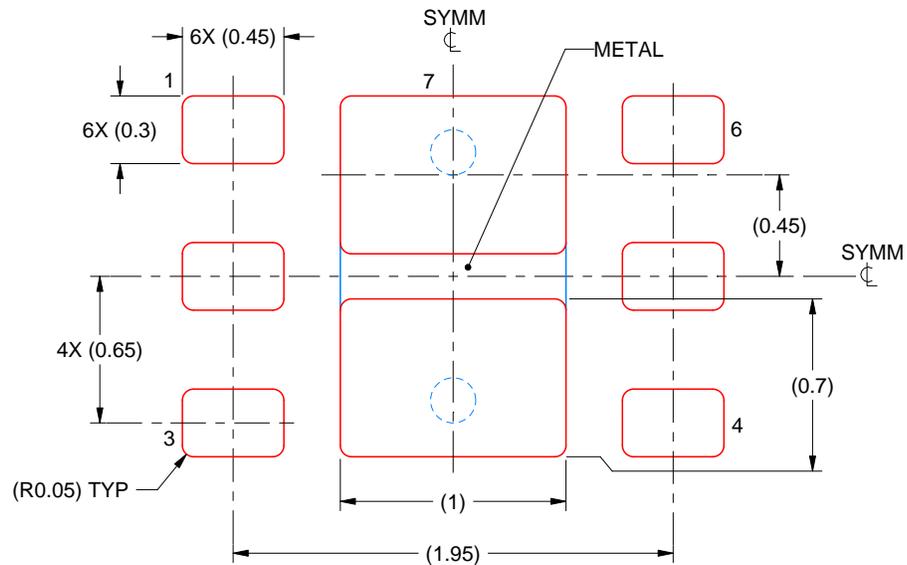
5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
6. Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.

EXAMPLE STENCIL DESIGN

DRV0006A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD #7
88% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:30X

4222173/C 11/2025

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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最終更新日 : 2025 年 10 月